

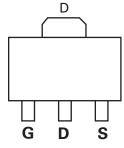
N-Channel 200 V (D-S) MOSFET

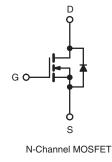
PRODUCT SUMMARY							
V _{DS} (V)	200						
R _{DS(on)} (Ω)	$V_{GS} = 10 V$	1.6					
Q _g (Max.) (nC)	8.2						
Q _{gs} (nC)	1.8						
Q _{gd} (nC)	4.5						
Configuration	Single						

FEATURES

- Available in tape and reel
- Dynamic dV/dt rating
- Repetitive avalanche rated
- Fast switching
- Ease of paralleling
- Simple drive requirements







ABSOLUTE MAXIMUM RATINGS (T _C	= 25 °C, unl	ess otherwis	se noted)			
PARAMETER	SYMBOL	LIMIT	UNIT			
Drain-Source Voltage		V _{DS}	200	v		
Gate-Source Voltage			V _{GS}	GS ± 20		
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 \ ^{\circ}{\rm C}$ $T_{\rm C} = 100 \ ^{\circ}{\rm C}$		1.0		
	VGS AL TO V	T _C = 100 °C	ID	0.6	А	
Pulsed Drain Current ^a			I _{DM}	3.7		
Linear Derating Factor				0.025	W/°C	
Linear Derating Factor (PCB Mount) e	-	0.017	W/C			
Single Pulse Avalanche Energy ^b			E _{AS}	50	mJ	
Repetitive Avalanche Current ^a			I _{AR}	0.96	А	
Repetitive Avalanche Energy ^a	E _{AR}	0.31	mJ			
Maximum Power Dissipation	T _C = 25 °C		D	3.1	w	
Maximum Power Dissipation (PCB Mount) e	T _A = 25 °C		PD	2.0		
Peak Diode Recovery dV/dt ^c	dV/dt	5.0	V/ns			
Operating Junction and Storage Temperature Rang	T _J , T _{stg} -55 to +150		°C			
Soldering Recommendations (Peak Temperature) ^d		300	U			

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. $V_{DD} = 50 \text{ V}$, starting $T_J = 25 \text{ °C}$, L = 81 mH, $R_G = 25 \Omega$, $I_{AS} = 0.96 \text{ A}$ (see fig. 12). c. $I_{SD} \le 3.3 \text{ A}$, dl/dt $\le 70 \text{ A/µs}$, $V_{DD} \le V_{DS}$, $T_J \le 150 \text{ °C}$.

d. 1.6 mm from case.

e. When mounted on 1" square PCB (FR-4 or G-10 material).



THERMAL RESISTANCE RATINGS							
PARAMETER	SYMBOL	MIN.	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient (PCB Mount) ^a	R _{thJA}	-	-	40	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	-	60			

Note

a. When mounted on 1" square PCB (FR-4 or G-10 material).

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} :	= 0 V, I _D = 250 μA	200	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	e to 25 °C, I _D = 1 mA	-	0.30	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μΑ	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}		$V_{GS} = \pm 20 V$	-	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 200 V, V _{GS} = 0 V /, V _{GS} = 0 V, T _J = 125 °C	-	-	25 250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 0.58 A ^b	-	1.6	-	Ω
Forward Transconductance	g _{fs}	V _{DS} =	= 50 V, I _D = 0.58 A	0.51	-	-	S
Dynamic		-					
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,	-	140	-	pF
Output Capacitance	C _{oss}		$V_{DS} = 25 V$,	-	53	-	
Reverse Transfer Capacitance	C _{rss}	f = 1	.0 MHz, see fig. 5	-	15	-	
Total Gate Charge	Qg			-	-	8.2	
Gate-Source Charge	Q_gs	$V_{GS} = 10 V$	$V_{GS} = 10 \text{ V}$ $I_D = 3.3 \text{ A}, V_{DS} = 160 \text{ V},$ see fig. 6 and 13 ^b		-	1.8	nC
Gate-Drain Charge	Q _{gd}			-	-	4.5	
Turn-On Delay Time	t _{d(on)}			-	8.2	-	- ns
Rise Time	t _r	V _{DD} =	-	17	-		
Turn-Off Delay Time	t _{d(off)}	$R_g = 24 \Omega$,	-	14	-		
Fall Time	t _f		-	8.9	-		
Internal Drain Inductance	L _D	6 mm (0.25")	Between lead, 6 mm (0.25") from package and center of die contact			-	nH
Internal Source Inductance	L _S					-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the		-	-	0.96	А
Pulsed Diode Forward Current ^a	I _{SM}	integral revers p - n junction	-	-	7.7		
Body Diode Voltage	V _{SD}	T_J = 25 °C, I_S = 0.96 A, V_{GS} = 0 V $^{\rm b}$		-	-	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T 05 %C 1	= 3.3 A, dl/dt = 100 A/µs ^b	-	150	310	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$I_{\rm J} = 25 {}^{\circ}{\rm C}, I_{\rm F}$	-	0.60	1.4	μC	
Forward Turn-On Time	t _{on}	Intrinsic tu	ırn-on time is negligible (turn	-on is dor	ninated b	y L _S and	L _D)

Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

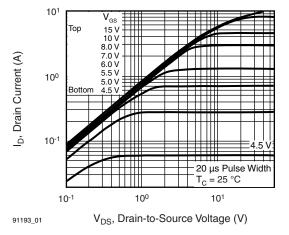


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

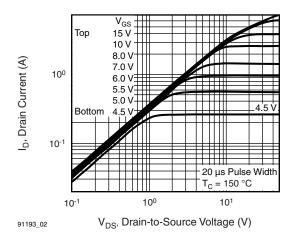


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C

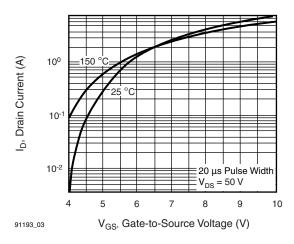


Fig. 3 - Typical Transfer Characteristics

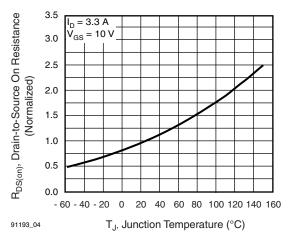


Fig. 4 - Normalized On-Resistance vs. Temperature

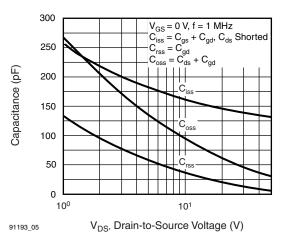


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

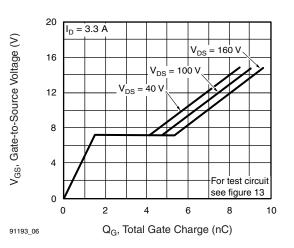


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

VBI1202K



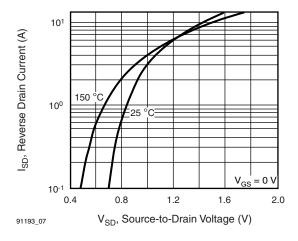


Fig. 7 - Typical Source-Drain Diode Forward Voltage

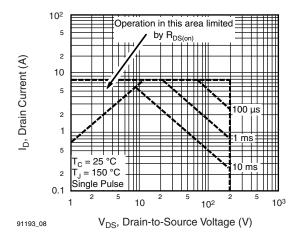


Fig. 8 - Maximum Safe Operating Area

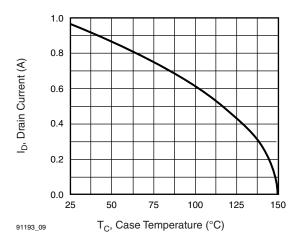


Fig. 9 - Maximum Drain Current vs. Case Temperature

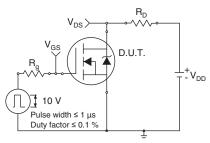


Fig. 10a - Switching Time Test Circuit

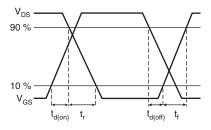
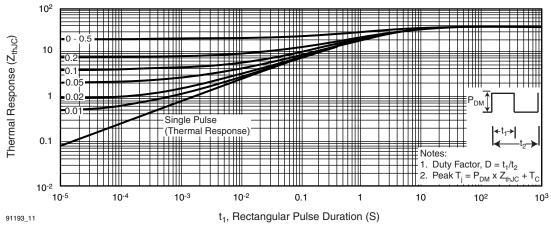


Fig. 10b - Switching Time Waveforms







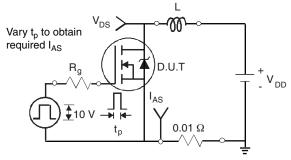


Fig. 12a - Unclamped Inductive Test Circuit

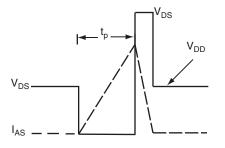


Fig. 12b - Unclamped Inductive Waveforms

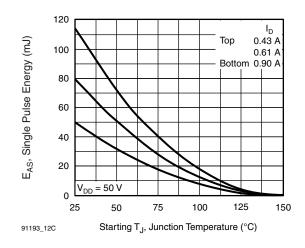


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

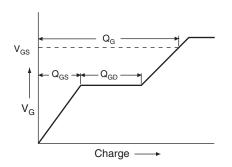


Fig. 13a - Basic Gate Charge Waveform

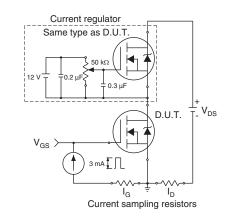
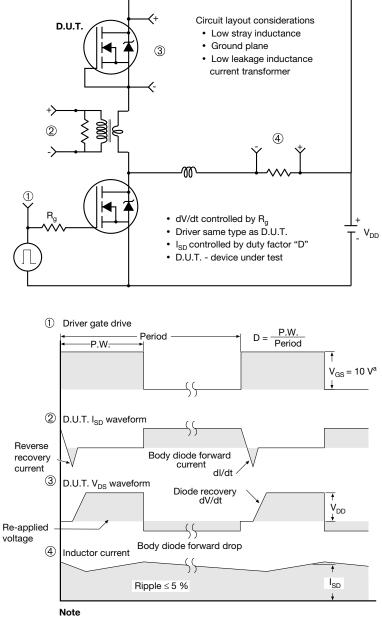


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit

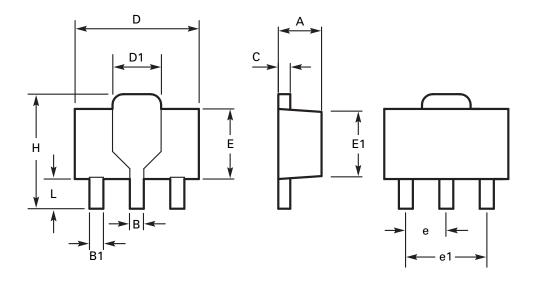


a. V_{GS} = 5 V for logic level devices

Fig. 14 - For N-Channel



Package outline - SOT89



DIM	Millimeters		Inc	Inches		Millimeters		Inches	
	Min	Max	Min	Max		Min	Max	Min	Max
А	1.40	1.60	0.550	0.630	E	2.29	2.60	0.090	0.102
В	0.44	0.56	0.017	0.022	E1	2.13	2.29	0.084	0.090
B1	0.36	0.48	0.014	0.019	е	1.50 BSC		0.059 BSC	
С	0.35	0.44	0.014	0.017	e1	3.00 BSC		0.118 BSC	
D	4.40	4.60	0.173	0.181	Н	3.94	4.25	0.155	0.167
D1	1.62	1.83	0.064	0.072	L	0.89	1.20	0.035	0.047

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches



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